

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/741,715	TACHIBANA ET AL.	
Examiner		Art Unit		Page 1 of 1
Christopher A. Revak		2131		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2005/0060146 A1	03-2005	Oh, Yoon-hark	704/229
	B	US-2002/0110260 A1	08-2002	Wakasu, Yutaka	382/100
	C	US-6,735,325 B2	05-2004	Wakasu, Yutaka	382/100
	D	US-6,453,053 B1	09-2002	Wakasu, Yutaka	382/100
	E	US-5,960,390 A	09-1999	Ueno et al.	704/200.1
	F	US-5,825,320 A	10-1998	Miyamori et al.	341/139
	G	US-5,752,224 A	05-1998	Tsutsui et al.	704/225
	H	US-5,731,767 A	03-1998	Tsutsui et al.	341/50
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.